Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | GREEN ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0037331 a1	02-2003	Lee , Jack Yiu-bun	725/32
*	В	US-6,637,031 b1	10-2003	Chou, Philip A.	725/87
*	C	US-2002/0024956 a1	02-2002	Keller-Tuberg, Stefan Paul	370/395.52
*	D	US-5,884,141	03-1999	Inoue et al.	725/101
*	E	US-5,724,646	03-1998	Ganek et al.	725/89
*	F	US-2003/0060196 a1	03-2003	Levinberg, Amiram	455/428
*	G	US-2004/0255328 a1	12-2004	Baldwin et al.	725/090
*	Н	US-2005/0190781 a1	09-2005	Green et al.	. 370/432
	- 1	US			
	7	US-			
•	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N.					
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	Р					
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	R				·	
	S					
	т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
n	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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